



## SINGLE-CHIP CHARGER AND DC/DC CONVERTER IC FOR PORTABLE APPLICATIONS (bq2501x)

### FEATURES

- Li-Ion Or Li-Pol Charge Management and Synchronous DC-DC Power Conversion In a Single Chip
- Optimized for Powering Bluetooth™ Headsets and Accessories
- Charges and Powers the System from Either the AC Adapter or USB with Autonomous Power Source Selection
- Integrated USB Charge Control with Selectable 100 mA and 500 mA Charge Rates
- Integrated Power FET and Current Sensor for Up to 500 mA Charge Applications AND 100 mA DC-DC Controller with Integrated FETs
- Reverse Leakage Protection Prevents Battery Drainage
- Automatic Power Save Mode For High Efficiency at Low Current, or Forced PWM for Frequency Sensitive Applications
- 3.5 mm × 4.5 mm QFN Package

### APPLICATIONS

- Bluetooth™ Headsets
- Bluetooth™ Accessories
- Low-Power Handheld Devices

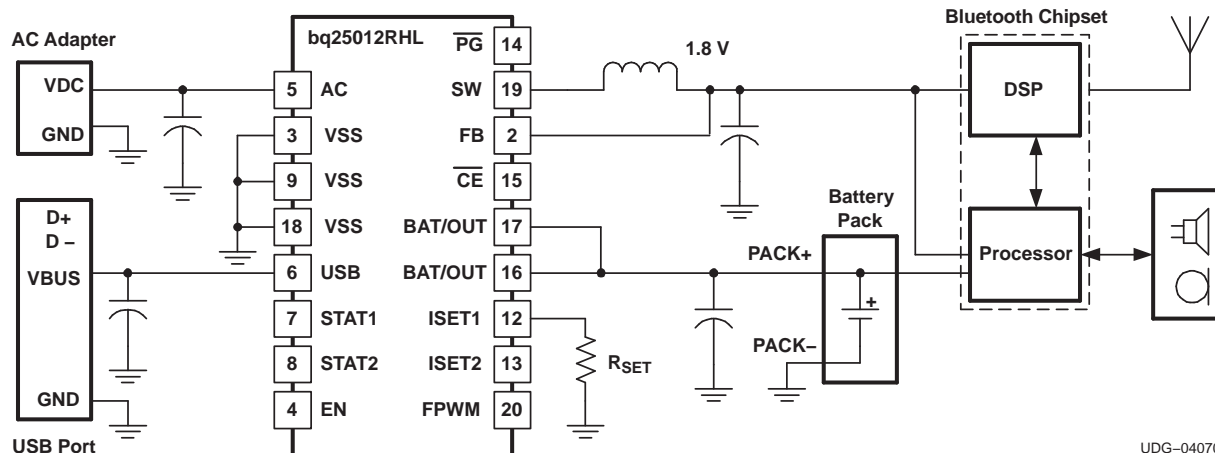
### DESCRIPTION

The bq2501x series are highly integrated charge and power management devices targeted at space-limited bluetooth applications. The bq2501x series offer integrated power FET and current sensor for charge control, reverse blocking protection, high accuracy current and voltage regulation, charge status, charge termination, and a highly efficient and low-power dc-dc converter in a small package.

The bq2501x charges the battery in three phases: conditioning, constant current and constant voltage. Charge is terminated based on minimum current. An internal charge timer provides a backup safety feature for charge termination. The bq2501x automatically re-starts the charge if the battery voltage falls below an internal threshold. The bq2501x automatically enters sleep mode when  $V_{CC}$  supply is removed.

The integrated low-power high-efficiency dc-dc converter is designed to operate directly from a single-cell Li-Ion or Li-Pol battery pack. The output voltage is either adjustable from 0.7 V to VBAT (bq25010), fixed at 3.3 V (bq25011), or fixed at 1.8 V (bq25012), and is capable of delivering up to 150-mA of load current. The dc-dc converter operates at a synchronized 1 MHz switching frequency allowing for the use of small inductors.

### TYPICAL APPLICATION



UDG-04070



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### ORDERING INFORMATION<sup>(1)</sup>

T <sub>A</sub>	OUTPUT VOLTAGE (V)	PART NUMBER <sup>(2)(3)</sup>	PACKAGE MARKING
-40°C to 125°C	Adjustable	bq25010RHLR	ANC
	3.3	bq25011RHLR <sup>(4)</sup>	ANE
	1.8	bq25012RHLR	ANF

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at [www.ti.com](http://www.ti.com)
- (2) The RHL package is available taped and reeled only in quantities of 3,000 devices per reel.
- (3) This product is RoHS compatible, including a lead concentration that does not exceed 0.1% of total product weight, and is suitable for use in specified lead-free soldering processes. In addition, this product uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.
- (4) Advanced Information, contact factory for availability.

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

		bq25010 bq25011 bq25012
Supply voltage	AC, USB (wrt VSS)	-0.3 V to 7 V
Input voltage	$\overline{PG}$ , OUT, ISET1, ISET2, STAT1, STAT2, TS (wrt VSS)	-0.3 V to 7 V
	EN, FB, FPWM, SW (wrt VSS)	V <sub>OUT</sub> + 0.3 V
Output sink/source current	$\overline{PG}$ , STAT1, STAT2	15 mA
	TS	200 $\mu$ A
Output source current	OUT	1.5 A
Storage temperature range, T <sub>stg</sub>		-65°C to 150°C
Junction temperature range, T <sub>J</sub>		0°C to 125°C
Lead temperature (soldering, 10 seconds)		260°C
ESD rating (human body model, HBM)		1500 V

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to the network ground terminal unless otherwise noted.

### RECOMMENDED OPERATING CONDITIONS

	MIN	MAX	UNIT
V <sub>CC</sub> Supply voltage (from AC input)	4.5	6.5	V
V <sub>CC</sub> Supply voltage (from USB input)	4.35	6.5	
T <sub>J</sub> Operating junction temperature range	-40	125	°C

### DISSIPATION RATINGS

PACKAGE	T <sub>A</sub> < 40°C POWER RATING	DERATING FACTOR ABOVE T <sub>A</sub> = 40°C	$\theta_{JA}$
20-pin RHL <sup>(1)</sup>	1.81 W	21 mW/°C	46.87°C/W

- (1) This data is based on using the JEDEC High-K board and the exposed die pad is connected to a Cu pad on the board. This is connected to the ground plane by a 2' via matrix.

## ELECTRICAL CHARACTERISTICS

over junction temperature range ( $0^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$ ) and the recommended supply voltage range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT CURRENT						
I <sub>CC</sub> (VCC)	Supply current 1, VCC	V <sub>VCC</sub> > V <sub>VCC(min)</sub>		1.2	2	mA
I <sub>CC</sub> (SLP)	Sleep current	Sum of currents into OUT/BAT, V <sub>VCC</sub> < V <sub>(SLP)</sub>		2	5	μA
I <sub>CC</sub> (STDBY)	Stand by current	$\overline{CE}$ = High, 0°C ≤ T <sub>J</sub> ≤ 85°C			150	
I <sub>IB</sub> (OUT)	Input current, OUT	Charge DONE, V <sub>VCC</sub> > V <sub>VCC(min)</sub> , I <sub>OUT</sub> (SW) = 0 mA, Converter not switching		15	35	
I <sub>IB</sub> (CE)	Input current, $\overline{CE}$				1	
CHARGE VOLTAGE REGULATION (V <sub>BAT(REG)</sub> + V <sub>(DO-MAX)</sub> ≤ V <sub>VCC</sub> , I <sub>(TERM)</sub> < I <sub>OUT(BAT)</sub> ≤ 0.5 A)						
V <sub>REG</sub> (BAT)	Charger regulation voltage			4.2		V
	Charge voltage regulation accuracy	T <sub>A</sub> = 25°C		−0.35%	0.35%	
				−1%	1%	
(V <sub>(AC)</sub> − V <sub>(OUT)</sub> )	AC dropout voltage	V <sub>OUT</sub> (BAT) = V <sub>REG</sub> (BAT), I <sub>OUT</sub> (BAT) = 0.5 A		175	250	mV
(V <sub>(USB)</sub> − V <sub>(OUT)</sub> )	USB dropout voltage	V <sub>OUT</sub> (BAT) = V <sub>REG</sub> (BAT), ISET2 = High		350	500	
		V <sub>OUT</sub> (BAT) = V <sub>REG</sub> (BAT), ISET2 = Low		60	100	
CHARGE CURRENT REGULATION						
I <sub>OUT</sub> (BAT)	AC output current range	V <sub>VCC</sub> ≥ 4.5 V, V <sub>OUT</sub> (BAT) = V <sub>(LOWV)</sub> , V <sub>VCC</sub> − V <sub>OUT</sub> (BAT) > V <sub>(DO-MAX)</sub> , I <sub>OUT</sub> (BAT) = (K <sub>(SET)</sub> × V <sub>(SET)</sub> / R <sub>SET</sub> )	50		500	mA
I <sub>OUT</sub> (BAT)	USB output current range	V <sub>VCC(min)</sub> ≥ 4.5 V, V <sub>OUT</sub> (BAT) = V <sub>(LOWV)</sub> , V <sub>VCC</sub> − V <sub>OUT</sub> (BAT) > V <sub>(DO-MAX)</sub> , ISET2 = Low	80		100	
		V <sub>VCC(min)</sub> ≥ 4.5 V, V <sub>OUT</sub> (BAT) = V <sub>(LOWV)</sub> , V <sub>VCC</sub> − V <sub>OUT</sub> (BAT) > V <sub>(DO-MAX)</sub> , ISET2 = High	400		500	
V <sub>(SET)</sub>	Output current set voltage	Voltage on ISET1, V <sub>VCC</sub> ≥ 4.5 V, V <sub>OUT</sub> (BAT) = V <sub>(LOWV)</sub> , V <sub>VCC</sub> − V <sub>OUT</sub> (BAT) > V <sub>(DO-MAX)</sub> , ISET2 = High	2.436	2.500	2.538	V
K <sub>(SET)</sub>	Output current set factor	50 mA ≤ I <sub>OUT</sub> (OUT) ≤ 500 mA	307	322	337	
		10 mA ≤ I <sub>OUT</sub> (OUT) ≤ 50 mA	296	320	346	
		10 mA ≤ I <sub>OUT</sub> (OUT) ≤ 10 mA	246	320	416	
PRECHARGE and SHORT-CIRCUIT CURRENT REGULATION						
V <sub>(LOWV)</sub>	Precharge to fast-charge transition threshold	Voltage on OUT/BAT	2.8	3	3.2	V
t <sub>PRECHG_DG</sub>	Deglintch time for fast-charge to precharge transition	V <sub>VCC(min)</sub> ≥ 4.5 V, t <sub>FALL</sub> = 100 ns, 10 mV overdrive, V <sub>IN</sub> (BAT) decreasing below threshold	250	375	500	ms
I <sub>OUT</sub> (PRECHG)	Precharge range	0 V < V <sub>IN</sub> (BAT) < V <sub>(LOWV)</sub> , t < t <sub>(PRECHG)</sub> , I <sub>OUT</sub> (PRECHG) = (K <sub>(SET)</sub> ∩ V <sub>(PRECHG)</sub> ) / R <sub>SET</sub>	5		100	mA
V <sub>(PRECHG)</sub>	Precharge set voltage	Voltage on ISET1, V <sub>REG</sub> (BAT) = 4.2 V, 0 V < V <sub>IN</sub> (BAT) < V <sub>(LOWV)</sub> , t < t <sub>(PRECHG)</sub>	240	255	270	mV
CHARGE TAPER and TERMINATION DETECTION						
I <sub>(TAPER)</sub>	Charge taper detection range	V <sub>IN</sub> (BAT) > V <sub>(RCH)</sub> , t < t <sub>(PRECHG)</sub> , I <sub>(TAPER)</sub> = (K <sub>(SET)</sub> ∩ V <sub>(TAPER)</sub> ) / R <sub>SET</sub>	5		100	mA
V <sub>(TAPER)</sub>	Charge taper detection set voltage	Voltage on ISET1, V <sub>REG</sub> (BAT) = 4.2 V, V <sub>IN</sub> (BAT) > V <sub>(RCH)</sub> , t < t <sub>(PRECHG)</sub>	235	250	265	mV
V <sub>(TERM)</sub>	Charge termination detection set voltage	Voltage on ISET1, V <sub>REG</sub> (BAT) = 4.2 V, V <sub>IN</sub> (BAT) > V <sub>(RCH)</sub> , t < t <sub>(PRECHG)</sub> , I <sub>(TERM)</sub> = (K <sub>(SET)</sub> ∩ V <sub>(TERM)</sub> ) / R <sub>SET</sub>	11	18	25	

**ELECTRICAL CHARACTERISTICS (continued)**over junction temperature range ( $0^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$ ) and the recommended supply voltage range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>TPRDET_DG</sub>	Deglitch time for taper detection	V <sub>VCC(min)</sub> ≥ 4.5 V, t <sub>FALL</sub> = 100 ns, 10 mV overdrive, I <sub>CHG</sub> increasing above or decreasing below threshold	250	375	500	ms
t <sub>TERMDDET_DG</sub>	Deglitch time for termination detection	V <sub>VCC(min)</sub> ≥ 4.5 V, t <sub>FALL</sub> = 100 ns, 10 mV overdrive, I <sub>CHG</sub> decreasing below threshold	350	375	500	
BATTERY RECHARGE THRESHOLD						
V <sub>RCH</sub>	Recharge threshold voltage		V <sub>REG(BAT)</sub> − 0.115	V <sub>REG(BAT)</sub> − 0.10	V <sub>REG(BAT)</sub> − 0.085	V
t <sub>RCHDET</sub>	Deglitch time for recharge detect	V <sub>VCC(min)</sub> ≥ 4.5 V, t <sub>FALL</sub> = 100 ns, 10 mV overdrive, I <sub>CHG</sub> decreasing below or increasing above threshold	250	375	500	ms
STAT1, STAT2 and $\overline{\text{PG}}$ OUTPUTS						
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 5 mA	0.25			V
ISET2 and $\overline{\text{CE}}$ INPUTS						
V <sub>IL</sub>	Low-level input voltage	I <sub>IL</sub> = 10 μA	0	0.4		V
V <sub>IH</sub>	High-level input voltage	I <sub>IL</sub> = 20 μA	1.4			
I <sub>IL</sub>	Low-level input current, $\overline{\text{CE}}$		−1			μA
I <sub>IH</sub>	High-level input current, $\overline{\text{CE}}$			1		
I <sub>IL</sub>	Low-level input current, ISET2	V <sub>ISET2</sub> = 0 V	−20			
I <sub>IH</sub>	High-level input current, ISET2	V <sub>ISET2</sub> = V <sub>CC</sub>		40		
I <sub>IHZ</sub>	High-Z input current, ISET2	V <sub>ISET2</sub> = High-Z		1		
TIMERS						
t <sub>(PRECHG)</sub>	Precharge time limit		1620	1800	1930	s
t <sub>(TAPER)</sub>	Taper time limit		1620	1800	1930	
t <sub>(CHG)</sub>	Charge time limit		16200	18000	19300	
I <sub>(FAULT)</sub>	Timer fault recovery current		200			μA
SLEEP COMPARATOR for CHARGER						
V <sub>(SLP)</sub>	Sleep mode entry threshold	2.3 V ≤ V <sub>IN(BAT)</sub> ≤ V <sub>REG(BAT)</sub>	V <sub>VCC</sub> ≤ V <sub>IN(BAT)</sub> +80 mV			V
V <sub>(SLP_DG)</sub>	Sleep mode exit threshold	2.3 V ≤ V <sub>IN(BAT)</sub> ≤ V <sub>REG(BAT)</sub>	V <sub>VCC</sub> ≥ V <sub>IN(BAT)</sub> +190 mV			
t <sub>(DEGL)</sub>	Deglitch time for sleep mode	V <sub>CC</sub> decreasing below threshold, t <sub>FALL</sub> = 100 ns, 10 mV overdrive,	250	375	500	ms
THERMAL SHUTDOWN						
T <sub>(SHTDWN)</sub>	Thermal trip threshold temperature		165			°C
	Thermal hysteresis		15			
UNDERVOLTAGE LOCKOUT AND POR						
V <sub>(UVLO_CHG)</sub>	Undervoltage lockout threshold voltage	Decreasing V <sub>CC</sub>	2.4	2.5	2.6	V
	Hysteresis		27			mV
V <sub>POR</sub>	POR threshold voltage <sup>(1)</sup>		2.3	2.4	2.5	V

(1) Ensured by design. Not production tested.

## ELECTRICAL CHARACTERISTICS (continued)

over junction temperature range ( $0^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$ ) and the recommended supply voltage range (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT	
DC-DC INPUT/OUTPUT CURRENT								
V <sub>(BAT)</sub>	Input voltage range	Input power absent		V <sub>(LOWV)</sub>	4.2		V	
		Input power present		V <sub>(UVLO)</sub>	4.2			
UVLO	Undervoltage lockout				2			
I <sub>OUT_L</sub>	Maximum output current				150		mA	
FPWM – bq25010								
V <sub>IH(FPWM)</sub>	High-level input voltage			2.0				
V <sub>IL(FPWM)</sub>	Low-level input voltage				0.4			
FPWM bq25011 and bq25012								
V <sub>IH(FPWM)</sub>	High-level input voltage			1.3			V	
V <sub>IL(FPWM)</sub>	Low-level input voltage				0.4			
I <sub>FPWM</sub>	Input bias current	V <sub>EN</sub> = GND or V <sub>BAT</sub> , V <sub>FPWM</sub> = GND or V <sub>BAT</sub>			0.01	0.1	μA	
ENABLE								
V <sub>IH(EN)</sub>	High-level input voltage			1.3			V	
V <sub>IL(EN)</sub>	Low-level input voltage				0.4			
I <sub>EN</sub>	Input bias current	V <sub>EN</sub> = GND or V <sub>BAT</sub> , V <sub>FPWM</sub> = GND or V <sub>BAT</sub>			0.01	0.1	μA	
POWER SWITCH								
R <sub>DS(on)</sub>	Internal P-channel MOSFET on-resistance	V <sub>IN</sub> = V <sub>GS</sub> = 3.6 V			0.97	1.52	Ω	
		V <sub>IN</sub> = V <sub>GS</sub> = 2.5 V			1.27	2.00		
	Internal N-channel MOSFET on-resistance	V <sub>IN</sub> = V <sub>GS</sub> = 3.6 V			0.68	1.19		
		V <sub>IN</sub> = V <sub>GS</sub> = 2.5 V			0.86	1.45		
I <sub>Igk(P)</sub>	P-channel leakage current	V <sub>DS</sub> = 6 V			0.1	1	μA	
I <sub>Igk(N)</sub>	N-channel leakage current	V <sub>DS</sub> = 6 V			0.1	1		
I <sub>(LIM)</sub>	P-channel current limit	2.5 V < V <sub>BAT</sub> < 4.2 V		190	230	350	mA	
OSCILLATOR								
f <sub>SW</sub>	Switching frequency			0.65	1	1.5	MHz	
OUTPUT								
V <sub>REF</sub>	Reference voltage	bq25010			0.5		V	
V <sub>FB</sub>	Feedback voltage <sup>(2)</sup>	bq25010	3.6 V ≤ V <sub>BAT</sub> ≤ 4.2 V, 0 mA ≤ I <sub>OUT</sub> ≤ 150 mA		–3%	+3%		
V <sub>DC-DC</sub>	Adjustable output voltage range	bq25010			0.7	V <sub>BAT</sub>		
	Fixed output voltage	bq25011	3.6 V ≤ V <sub>BAT</sub> ≤ 4.2 V, 0 mA ≤ I <sub>OUT</sub> ≤ 150 mA		3.2	3.3		3.4
		bq25012	3.6 V ≤ V <sub>BAT</sub> ≤ 4.2 V, 0 mA ≤ I <sub>OUT</sub> ≤ 150 mA		1.746	1.8		1.854

(2) For output voltages  $\leq 1.2 \text{ V}$  a 22- $\mu\text{F}$  output capacitor value is required to achieve a maximum output voltage accuracy of +3% while operating in power save mode (PFM).

## TYPICAL OPERATING CHARACTERISTICS

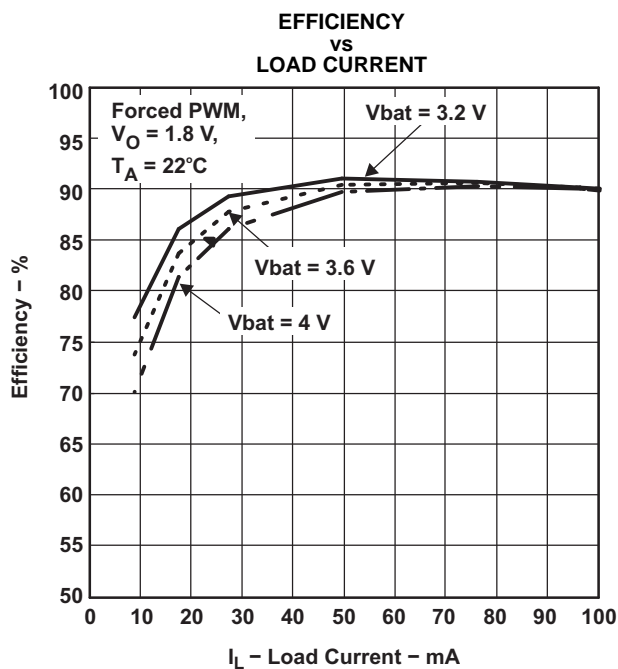


Figure 1.

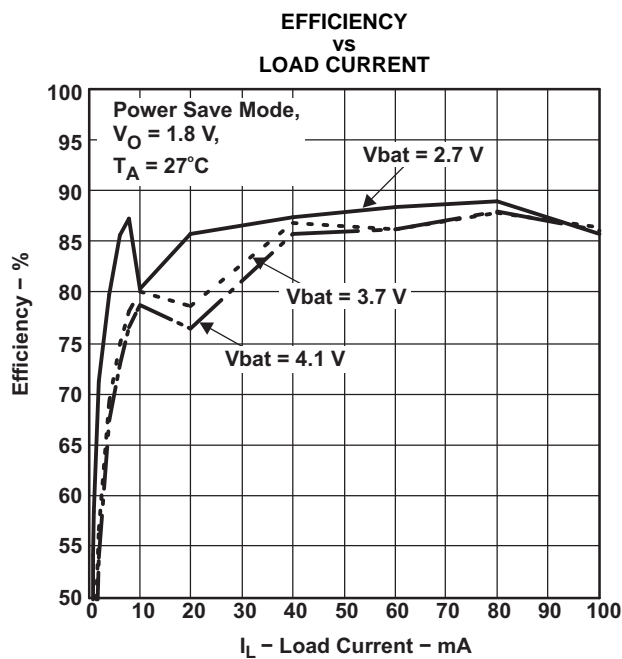
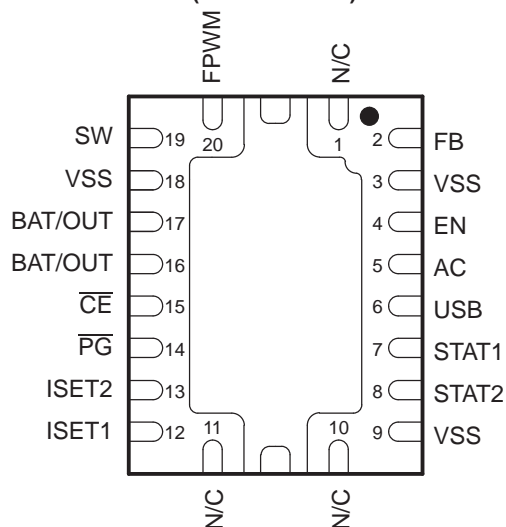


Figure 2.

## DEVICE INFORMATION

bq25010, bq25011, bq25012

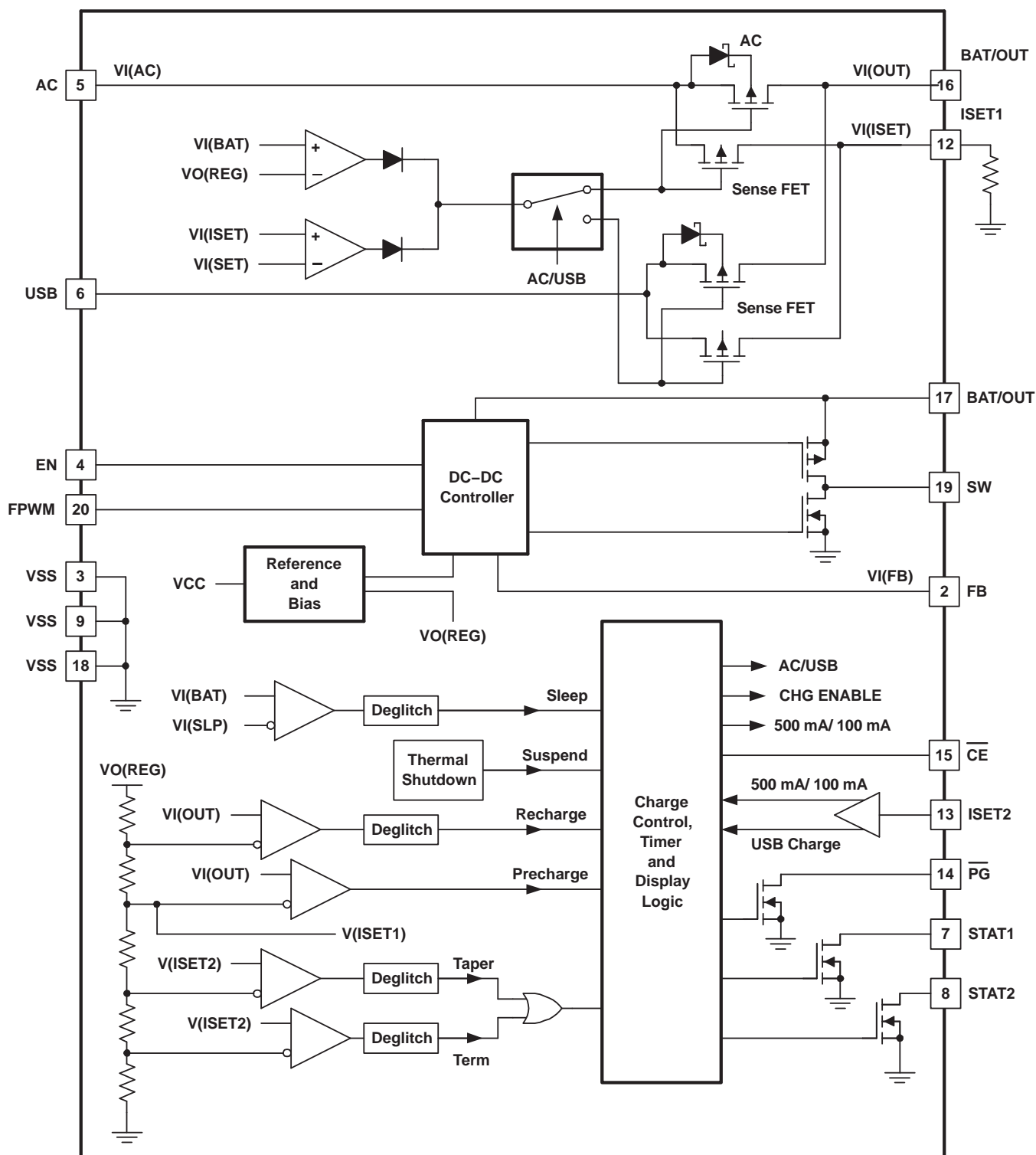
RHL PACKAGE  
(BOTTOM VIEW)



## TERMINAL FUNCTIONS

TERMINAL		I/O	DESCRIPTION
NAME	NO.		
AC	5	I	Charge input voltage from AC adapter
BAT/OUT	16	I/O	Charge current output
BAT/OUT	17	I	Battery input to DC-DC converter
$\overline{CE}$	15	I	Charge enable input (active low)
EN	4	I	Enable input for DC-DC converter (active high)
FB	2	I	Feedback pin for DC-DC converter
FPWM	20	I	PWM control input for the DC-DC converter. A high on FPWM = forced PWM mode. A low = power save mode.
ISSET1	12	I	Charge current set point for AC input and precharge and taper set point for both AC and USB
ISSET2	13	I	Charge current set point for USB port (High = 500 mA, Low = 100 mA, High-Z = disable USB charge)
NC	1, 10, 11	–	No connect. These pins must be left floating.
$\overline{PG}$	14	O	Power good status output (active low)
STAT1	7	O	Charge status output 1 (open-drain)
STAT2	8	O	Charge status output 2 (open-drain)
SW	19	O	Phase node of the DC-DC converter
USB	6	I	Charge input voltage from USB adapter
VSS	3, 9, 18	–	Ground Input. Also note that there is an internal electrical connection between the exposed thermal pad and VSS pins of the device. The exposed thermal pad must be connected to the same potential as the Vss pin on the printed circuit board. Do not use the thermal pad as the primary ground input for the device. All VSS pins must be connected to ground at all times.

# FUNCTIONAL BLOCK DIAGRAM



UDG-04072



## FUNCTIONAL DESCRIPTIONS

### BATTERY CHARGER

The bq2501x supports a precision Li-Ion or Li-Pol charging system suitable for single-cell battery packs and a low-power DC-DC converter for providing power to system processor. See a typical charge profile, application circuit and an operational flow chart in [Figure 3](#) through [Figure 5](#) respectively.

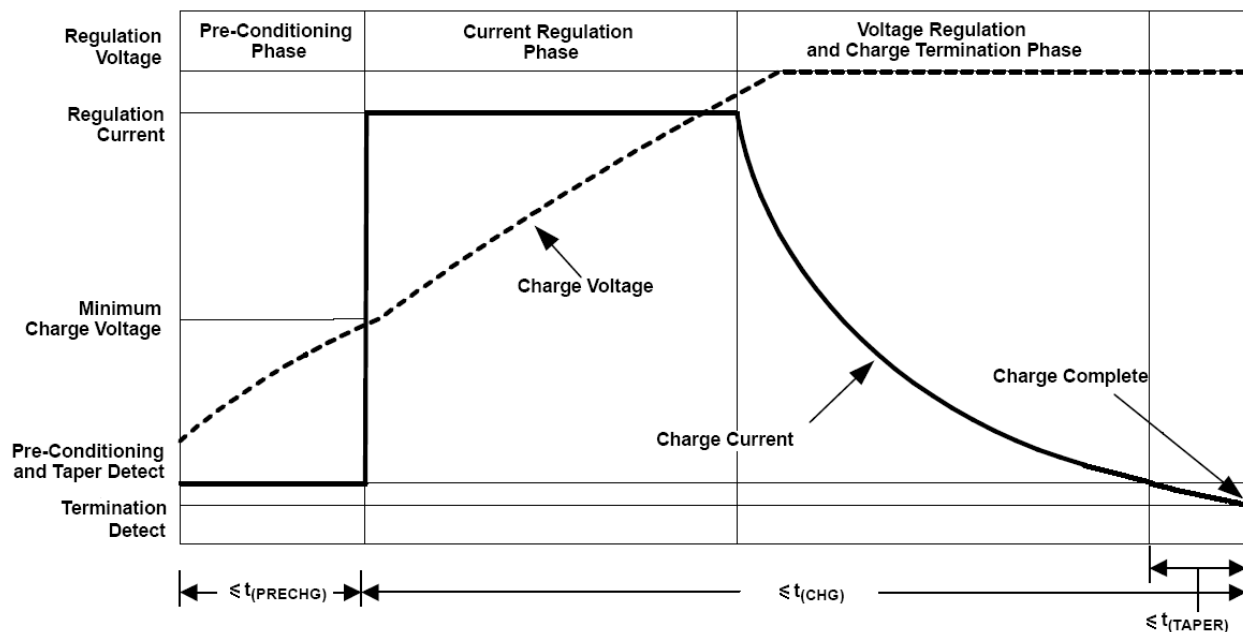
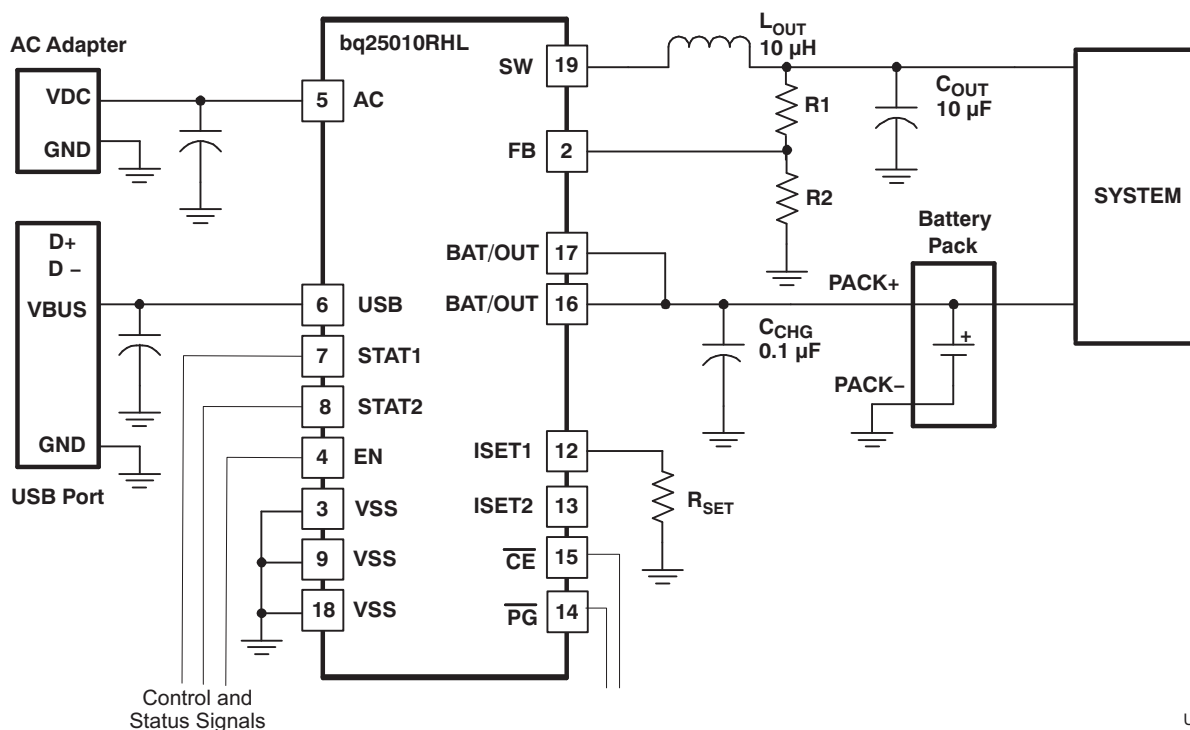


Figure 3. Typical Charger Profile



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Figure 4. Typical Application Circuit

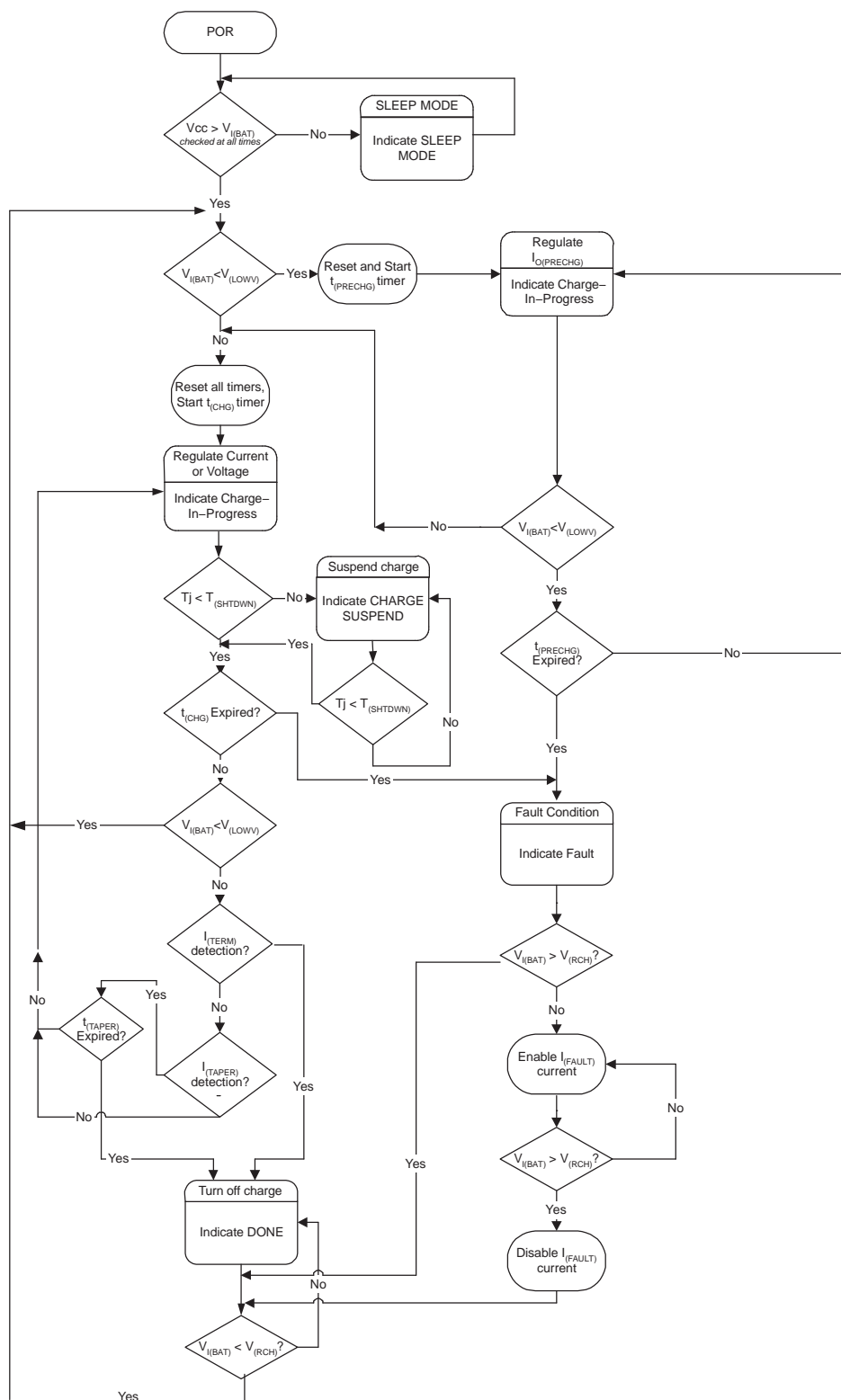


Figure 5. Operational Flow Chart

## Autonomous Power Source Selection

As default, the bq2501x attempts to charge the battery from the AC input. If AC input is not present, the USB input is selected. If both inputs are available, the AC adapter has the priority. Refer to [Figure 6](#) for details.

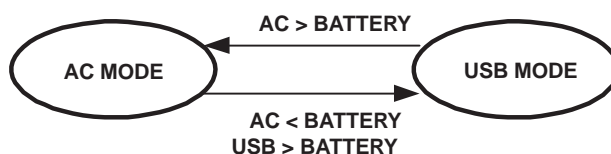


Figure 6. Power Source Selection

## Battery Pre-Conditioning

During a charge cycle if the battery voltage is below the  $V_{(LOWV)}$  threshold, the bq2501x applies a precharge current,  $I_{O(PRECHG)}$ , to the battery. This feature revives deeply discharged cells. The resistor connected between the ISET1 and VSS pins,  $R_{SET}$ , determines the precharge rate. The  $V_{(PRECHG)}$  and  $K_{(SET)}$  parameters are specified in the specifications table.

$$I_{O(PRECHG)} = \frac{V_{(PRECHG)} \times K_{(SET)}}{R_{SET}} \quad (1)$$

The bq2501x activates a safety timer,  $t_{(PRECHG)}$ , during the conditioning phase. If  $V_{(LOWV)}$  threshold is not reached within the timer period, the bq2501x turns off the charger and enunciates FAULT on the STAT1 and STAT2 pins. Please refer to *Timer Fault Recovery* section for additional details.

## Battery Charge Current

The bq2501x offers on-chip current regulation with programmable set point. The resistor connected between the ISET1 and VSS pins,  $R_{SET}$ , determines the charge rate. The  $V_{(SET)}$  and  $K_{(SET)}$  parameters are specified in the specifications table.

$$I_{O(OUT)} = \frac{V_{(SET)} \times K_{(SET)}}{R_{SET}} \quad (2)$$

When charging from a USB port, the host controller has the option of selecting either 100 mA or 500 mA charge rate using the ISET2 pin. A low-level signal sets the current at 100 mA and a high-level signal sets the current at 500 mA. A high-Z input disables USB charging.

## Battery Voltage Regulation

The voltage regulation feedback is through the BAT/OUT pin. This input is tied directly to the positive side of the battery pack. The bq2501x monitors the battery-pack voltage between the BAT/OUT and VSS pins. When the battery voltage rises to  $V_{O(REG)}$  threshold, the voltage regulation phase begins and the charging current begins to taper down.

As a safety backup, the bq2501x also monitors the charge time in the charge mode. If taper threshold is not detected within this time period,  $t_{(CHG)}$ , the bq2501x turns off the charger and enunciates FAULT on the STAT1 and STAT2 pins. Please refer to section titled *Timer Fault Recovery* section for additional details.

## Charge Taper Detection, Termination and Recharge

The bq2501x monitors the charging current during the voltage regulation phase. Once the taper threshold,  $I_{(TAPER)}$ , is detected the bq2501x initiates the taper timer,  $t_{(TAPER)}$ . Charge is terminated after the timer expires. The resistor connected between the ISET1 and VSS pins,  $R_{SET}$ , determines the taper detection level. The  $V_{(TAPER)}$  and  $K_{(SET)}$  parameters are specified in the specifications table. Note that this applies to both AC and USB charging.

$$I_{(TAPER)} = \frac{V_{(TAPER)} \times K_{(SET)}}{R_{SET}} \quad (3)$$

The bq2501x resets the taper timer in the event that the charge current returns above the taper threshold,  $I_{(TAPER)}$ .

In addition to the taper current detection, the bq2501x terminates charge in the event that the charge current falls below the  $I_{(TERM)}$  threshold. This feature allows for quick recognition of a battery removal condition or insertion of a fully charged battery. Note that taper timer is not activated. The resistor connected between the ISET1 and VSS pins,  $R_{SET}$ , determines the taper detection level. The  $V_{(TERM)}$  and  $K_{(SET)}$  parameters are specified in the specifications table. Note that this applies to both AC and USB charging.

$$I_{(TERM)} = \frac{V_{(TERM)} \times K_{(SET)}}{R_{SET}} \quad (4)$$

After charge termination, the bq2501x restarts the charge once the voltage on the BAT/OUT pin falls below the  $V_{(RCH)}$  threshold. This feature keeps the battery at full capacity at all times.

### Sleep Mode for Charger

The bq2501x enters the low-power sleep mode if both AC and USB are removed from the circuit. This feature prevents draining the battery during the absence of  $V_{CC}$ .

### Operation Modes

Operational modes of the bq2501x are summarized in [Table 1](#). Operation of DC-DC is not recommended while charger is in precharge mode.

**Table 1. Operation Modes**

BATTERY VOLTAGE	AC or USB ADAPTER STATUS	CHARGER STATUS	DC-DC STATUS
$V_{I(BAT)} > V_{(LOWV)}$	Present	Fast	EN
$0 V < V_{I(BAT)} < V_{(LOWV)}$	Present	Precharge	EN
$V_{I(BAT)} < V_{(UVLO)}$	Both absent	Off	Off

### Status Outputs

The STAT1 and STAT2 open-drain outputs indicate various charger and battery conditions as shown in [Table 2](#). These status pins can be used to communicate to the host processor. Note that OFF indicates the open-drain transistor is turned off.

**Table 2. Status Pins Summary**

CHARGE STATE	INPUT POWER STATE	STAT1	STAT2
Precharge in progress	Present	ON	ON
Fast charge in progress	Present	ON	OFF
Charge done	Not reported	OFF	ON
Timer fault	Not reported	OFF	OFF
Speel mode	Absent	OFF	OFF

### $\overline{PG}$ Output (Power Good)

The open-drain  $\overline{PG}$  output indicates when the AC adapter is present. The output turns ON when a valid voltage is detected. This output is turned off in the sleep mode. The  $\overline{PG}$  pin can be used to drive an LED or communicate to the host processor.

## **$\overline{\text{CE}}$ Input (Charge Enable)**

The  $\overline{\text{CE}}$  digital input is used to enable or disable the charge process. A low-level signal on this pin enables the charge and a high-level signal disables the charge and places the device into a low-power mode. A high-to-low transition on this pin also resets all timers and timer fault conditions. Note that this applies to both AC and USB charging.

## **Thermal Shutdown and Protection**

The bq2501x monitors the junction temperature,  $T_J$ , of the die and suspends charging if  $T_J$  exceeds  $T_{(\text{SHTDWN})}$ . Charging resumes when  $T_J$  falls below  $T_{(\text{SHTDWN})}$  by approximately 15°C.

## **Timer Fault Recovery**

As shown in [Figure 5](#), bq2501x provides a recovery method to deal with timer fault conditions. The following summarizes this method:

**Condition 1:** Charge voltage above recharge threshold ( $V_{(\text{RCH})}$ ) and timeout fault occurs.

Recovery method: bq2501x waits for the battery voltage to fall below the recharge threshold. This could happen as a result of a load on the battery, self-discharge or battery removal. Once the battery falls below the recharge threshold, the bq2501x clears the fault and starts a new charge cycle. A POR or  $\overline{\text{CE}}$  toggle also clears the fault.

**Condition 2:** Charge voltage below recharge threshold ( $V_{(\text{RCH})}$ ) and timeout fault occurs.

Recovery method: Under this scenario, the bq2501x applies the  $I_{(\text{FAULT})}$  current. This small current is used to detect a battery removal condition and remains on as long as the battery voltage stays below the recharge threshold. If the battery voltage goes above the recharge threshold, then the bq2501x disables the  $I_{(\text{FAULT})}$  current and executes the recovery method described for Condition 1. Once the battery falls below the recharge threshold, the bq2501x clears the fault and starts a new charge cycle. A POR or  $\overline{\text{CE}}$  toggle also clears the fault.

## **DC-DC CONVERTER**

The bq2501x provides a low quiescent-current synchronous DC-DC converter. The internally compensated converter is designed to operate over the entire voltage range of a single-cell Li-Ion or Li-Pol battery. Under nominal load current, the device operates with a fixed PWM switching frequency of typically 1 MHz. At light load currents, the device enters the power save mode of operation; the switching frequency is reduced and the quiescent current drawn by the converter from the BAT/OUT pin is typically only 15  $\mu\text{A}$ .

During PWM operation the converter uses a unique fast-response voltage mode controller scheme with input voltage feedforward to achieve good line and load regulation allowing the use of small ceramic input and output capacitors. At the beginning of each clock cycle initiated by the clock signal (S), the P-channel MOSFET switch is turned on and the inductor current ramps up until the comparator trips and the control logic turns off the switch. The current limit comparator also turns off the switch in case the current limit of the P-channel switch is exceeded. After the dead time preventing current shoot through the N-channel MOSFET rectifier is turned on and the inductor current ramps down. The next cycle is initiated by the clock signal again turning off the N-channel rectifier and turning on the on the P-channel switch. The  $g_M$  amplifier as well as the input voltage determines the rise time of the saw-tooth generator and therefore any change in input voltage or output voltage directly controls the duty cycle of the converter giving a very good line and load transient regulation.

## **Power Save Mode Operation**

As the load current decreases, the converter enters the power save mode operation. During power save mode, the converter operates with reduced switching frequency in PFM mode and with a minimum quiescent current to maintain high efficiency.

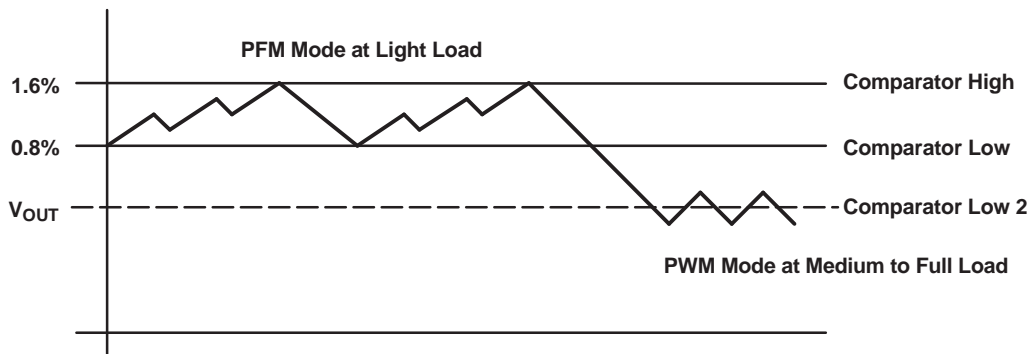
Two conditions allow the converter to enter the power save mode operation. One is the detection of discontinuous conduction mode. The other is when the peak switch current in the P-channel switch goes below the skip current limit. The typical skip current limit can be calculated as:

$$I_{\text{SKIP}} = 66 \text{ mA} + \frac{V_{\text{IN}}}{160 \, \Omega} \quad (5)$$

During the power save mode, the output voltage is monitored with the comparator by the thresholds comp low and comp high. As the output voltage falls below the comp low threshold (set to typically 0.8% above  $V_{\text{OUT}}$  nominal), the P-channel switch turns on. The P-channel switch is turned off as the peak switch current is reached. The typical peak switch current can be calculated as:

$$I_{\text{PEAK}} = 66 \text{ mA} + \frac{V_{\text{IN}}}{80 \, \Omega} \quad (6)$$

The N-channel rectifier is turned on and the inductor current ramps down. As the inductor current approaches zero, the N-channel rectifier is turned off, and the P-channel switch is turned on starting the next pulse. The converter continues these pulses until the comp high threshold (set to typically 1.6% above  $V_{\text{OUT}}$  nominal) is reached. The converter enters a sleep mode, reducing the quiescent current to a minimum. The converter wakes up again as the output voltage falls below the comp low threshold again. This control method reduces the quiescent current to typically to 15  $\mu\text{A}$  and the switching frequency to a minimum; thereby, achieving high converter efficiency. Setting the skip current thresholds to typically 0.8% and 1.6% above the nominal output voltage at light load current results in a dynamic output voltage achieving lower absolute voltage drops during heavy load transient changes. This allows the converter to operate with a small output capacitor of only 10  $\mu\text{F}$  and still have a low absolute voltage drop during heavy load transient changes. Refer to [Figure 7](#) as well for detailed operation of the power save mode.



**Figure 7. Power Save Mode Thresholds and Dynamic Voltage Positioning**

The converter enters the fixed-frequency PWM mode again as soon as the output voltage drops below the comp low 2 threshold.

### Dynamic Voltage Positioning

As described in the power save mode operation section and as detailed in [Figure 7](#), the output voltage is typically 0.8% above the nominal output voltage at light load currents as the device is in power save mode. This gives additional headroom for the voltage drop during a load transient from light load to full load. During a load transient from full load to light load the voltage overshoot is also minimized due to active regulation turning on the N-Channel rectifier switch.

### Soft-Start

The bq2501x has an internal soft-start circuit that limits the inrush current during startup. This soft-start is implemented as a digital circuit increasing the switch current in steps of typically 30 mA, 60 mA, 120 mA and then the typical switch current limit of 230 mA. Therefore the startup time depends mainly on the output capacitor and load current. Typical startup time with a 10- $\mu\text{F}$  output capacitor and a 100-mA load current is 1.6 ms.

## 100% Duty Cycle Low Dropout Operation

The bq2501x offers a low input-to-output voltage difference while still maintaining operation with the use of the 100% duty cycle mode. In this mode the P-channel switch is constantly turned on. This is particularly useful in battery-powered applications to achieve longest operation time by taking full advantage of the whole battery voltage range. The minimum input voltage to maintain regulation depends on the load current and output voltage and can be calculated as:

$$V_{IN(min)} = V_{OUT(max)} + I_{OUT(max)} \times (R_{DS(on)MAX} + R_L) \quad (7)$$

where

$I_{OUT(max)}$  = maximum output current plus inductor ripple current

$R_{DS(on)MAX}$  = maximum P-channel switch  $R_{DS(on)}$

$R_L$  = DC resistance of the inductor

$V_{OUT(max)}$  = nominal output voltage plus maximum output voltage tolerance

## Enable

Pulling the enable pin ( $\overline{EN}$ ) low forces the DC-DC converter into shutdown mode, with a shutdown quiescent current of typically 0.1  $\mu$ A. In this mode the P-channel switch and N-channel rectifier are turned off, the internal resistor feedback divider is disconnected, and the converter enters shutdown mode. If an output voltage, which could be an external voltage source or a super capacitor, is present during shut down, the reverse leakage current is specified under electrical characteristics. For proper operation the  $\overline{EN}$  pin must be terminated and should not be left floating.

Pulling the  $\overline{EN}$  pin high starts up the DC-DC converter with the soft-start as previously described.

## Undervoltage Lockout

The undervoltage lockout circuit prevents the converter from turning on the switch or rectifier MOSFET at low input voltages or under undefined conditions.

## Forced PWM Mode

The FPWM input pin allows the host system to override the power save mode by driving the FPWM pin high. In this state, the DC-DC converter remains in the PWM mode of operation with continuous current conduction regardless of the load conditions. Tying the FPWM pin low allows the device to enter power save mode automatically as previously described.

## APPLICATION INFORMATION

### ADJUSTABLE OUTPUT VOLTAGE VERSION (bq25010)

When the adjustable output voltage version of the bq2501x is being used (bq25010), the output is set by the external resistor divider, as shown in [Figure 4](#).

The output voltage can be calculated as:

$$V_{OUT} = 0.5 \text{ V} \times \left(1 + \frac{R1}{R2}\right) \quad (8)$$

where

$$R1 + R2 \leq 1 \text{ M}\Omega$$

$$\text{Internal reference voltage } V_{REF(typ)} = 0.5 \text{ V}$$

C1 and C2 should be selected as:

$$C1 = \frac{1}{2\pi \times 10 \text{ kHz} \times R1} \quad (9)$$

where

R1 = upper resistor of the voltage divider

C1 = upper capacitor of the voltage divider

For C1, a value should be chosen that comes closest to the calculated result.

$$C2 = \frac{R1}{R2} \times C1 \quad (10)$$

where

R2 = lower resistor of the voltage divider

C2 = lower capacitor of the voltage divider

For C2, the selected capacitor value should always be selected larger than the calculated result. For example, in [Figure 4](#), a 100-pF capacitor is selected for a calculated result of  $C2 = 86.17 \text{ pF}$ .

If quiescent current is not a key design parameter, C1 and C2 can be omitted and a low-impedance feedback divider must be used with  $R1 + R2 < 100 \text{ k}\Omega$ . This design reduces the noise available on the feedback pin (FB) as well, but increases the overall quiescent current during operation.

### FIXED OUTPUT VOLTAGE VERSION (bq25011, bq25012)

When a fixed output voltage version of the device is being used, no external resistive divider network is necessary. In this case, the output of the inductor should be connected directly the FB pin, as shown in [Figure 4](#).

### INPUT CAPACITOR SELECTION

In most applications, all that is needed is a high-frequency decoupling capacitor. A 0.1- $\mu\text{F}$  ceramic, placed in close proximity to AC/USB and VSS pins, works fine. The bq2501x is designed to work with both regulated and unregulated external DC supplies. If a non-regulated supply is chosen, the supply unit should have enough capacitance to hold up the supply voltage to the minimum required input voltage at maximum load. If not, more capacitance has to be added to the input of the charger.

### CHARGER OUTPUT CAPACITOR (DC-DC CONVERTER INPUT CAPACITOR) SELECTION

Because the buck converter has a pulsating input current, a low ESR input capacitor is required. This results in the best input voltage filtering and minimizes the interference with other circuits caused by high input voltage spikes. Also, the input capacitor must be sufficiently large to stabilize the input voltage during heavy load transients.

For good input voltage filtering, a 4.7- $\mu\text{F}$  input capacitor is normally sufficient, and can be increased without any limit for better input voltage filtering.

If ceramic output capacitors are used, the capacitor RMS ripple current rating ensures the application requirements. For completeness, the RMS ripple current is calculated as:



$$I_{\text{RMS}} = I_{\text{OUT(max)}} \times \sqrt{\frac{V_{\text{OUT}}}{V_{\text{IN}}} \times \left(1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}}\right)} \quad (11)$$

The worst case RMS ripple current occurs at  $D = 0.5$  and is calculated as:

$$I_{\text{RMS}} = \frac{I_{\text{OUT}}}{2} \quad (12)$$

Ceramic capacitors perform well because of the low ESR value, and they are less sensitive to voltage transients and spikes compared to tantalum capacitors. The input capacitor should be placed as close as possible to the BAT/OUT pin of the device for best performance. Refer to [Table 1](#) for recommended components.

## DC-DC CONVERTER OUTPUT CAPACITOR SELECTION

The advanced fast response voltage mode control scheme of the bq2501x allows the use of tiny ceramic capacitors without having large output voltage under and overshoots during heavy load transients. Ceramic capacitors having low ESR values have the lowest output voltage ripple and are therefore recommended. If required, tantalum capacitors may be used as well (refer to [Table 1](#) for recommended components). If ceramic output capacitors are used, the capacitor RMS ripple current rating always meets the application requirements. For completeness, the RMS ripple current is calculated as:

$$I_{\text{RMS(Cout)}} = V_{\text{OUT}} \times \frac{\left(1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}}\right)}{L \times f} \times \frac{1}{2 \times \sqrt{3}} \quad (13)$$

At nominal load current, the device operates in PWM mode and the overall output voltage ripple is the sum of the voltage spike caused by the output capacitor ESR plus the voltage ripple caused by charging and discharging the output capacitor:

$$\Delta V_{\text{OUT}} = V_{\text{OUT}} \times \frac{\left(1 - \frac{V_{\text{OUT}}}{V_{\text{IN}}}\right)}{L \times f} \times \left(\frac{1}{8 \times C_{\text{OUT}} \times f} + \text{ESR}\right) \quad (14)$$

where the output voltage ripple occurs at the highest input voltage  $V_{\text{IN}}$ .

At light load currents, the device operates in power save mode, and the output voltage ripple is independent of the output capacitor value. The output voltage ripple is set by the internal comparator thresholds. The typical output voltage ripple is 1% of the output voltage  $V_{\text{OUT}}$ .

## DC-DC CONVERTER OUTPUT INDUCTOR SELECTION

For high efficiencies, the inductor should have a low dc resistance to minimize conduction losses. Although the inductor core material has less effect on efficiency than its dc resistance, an appropriate inductor core material must be used. The inductor value determines the inductor ripple current. The larger the inductor value, the smaller the inductor ripple current, and the lower the conduction losses of the converter. On the other hand, larger inductor values causes a slower load transient response. Usually the inductor ripple current, as calculated below, should be around 30% of the average output current.

In order to avoid saturation of the inductor, the inductor should be rated at least for the maximum output current of the converter plus the inductor ripple current that is calculated as:

$$\Delta I_L = V_{OUT} \times \frac{\left(1 - \frac{V_{OUT}}{V_{IN}}\right)}{L \times f} \quad (15)$$

where

$f$  = switching frequency (1 MHz typical, 650 kHz minimal)

$L$  = inductor value

$\Delta I_L$  = peak-to-peak inductor ripple current

$I_{L(max)}$  = maximum inductor current

The highest inductor current occurs at maximum  $V_{IN}$ . A more conservative approach is to select the inductor current rating just for the maximum switch current of 350 mA. The internal compensator is designed in such a way that the optimized resonant frequency of the output inductor and capacitor is approximately 16 kHz. The recommended inductor and capacitor values for various output current are given in [Table 3](#).

**Table 3. Recommended Inductor and Capacitor Values**

TYPICAL OUTPUT CURRENT (mA)	INDUCTOR VALUE ( $\mu$ H)	CAPACITOR VALUE ( $\mu$ F)	APPLICATION
30	100	1	For low current, smallest capacitor
60	47	2.2	For low current, small capacitor
80	33	3.3	For medium current, small capacitor
120	22	4.7	For medium current
150	10	10	For highest current, smallest inductor

## CHARGING WHILE UNDER LOAD

The bq2501x is designed such that maximum charging safety and efficiency can be obtained by suspending normal operation while the device is actively charging the battery. In this mode of operation, the timeout function prevents a defective battery from being charged indefinitely. If charging does not terminate normally within five hours, the device annunciates a fault condition on the STAT1 and STAT2 pins as indicated in [Table 2](#).

If a load is applied to the device while it is being used to charge a battery, a false fault condition may result due to a slower rate of charge being applied to the battery. For this reason, it is recommended that the load be disconnected from the bq2501x while it is charging a battery.

## THERMAL CONSIDERATIONS

The bq2501x is packaged in a thermally enhanced MLP package. The package includes a thermal pad to provide an effective thermal contact between the device and the printed circuit board (PCB). Full PCB design guidelines for this package are provided in the application note *QFN/SON PCB Attachment* (SLUA271). The most common measure of package thermal performance is thermal impedance ( $\theta_{JA}$ ) measured (or modeled) from the chip junction to the air surrounding the package surface (ambient). The mathematical expression for  $\theta_{JA}$  is:

$$\theta_{JA} = \frac{T_J - T_A}{P} \quad (16)$$

where

$T_J$  = chip junction temperature

$T_A$  = ambient temperature

P = device power dissipation

Factors that can greatly influence the measurement and calculation of  $\theta_{JA}$  include:

- Whether or not the device is board mounted
- Trace size, composition, thickness, and geometry
- Orientation of the device (horizontal or vertical)
- Volume of the ambient air surrounding the device under test and airflow
- Whether other surfaces are in close proximity to the device being tested

The device power dissipation (P) is a function of the charge rate and the voltage drop across the internal power FET. It can be calculated from the following equation:

$$P = (V_{IN} - V_{IN(BAT)}) \times I_{OUT(OUT)} \quad (17)$$

Due to the charge profile of Li-xx batteries, the maximum power dissipation is typically seen at the beginning of the charge cycle when the battery voltage is at its lowest.

## PCB LAYOUT CONSIDERATIONS

For all switching power supplies, the layout is an important step in the design, especially at high peak currents and switching frequencies. If the layout is not carefully done the regulator could exhibit stability problems as well as EMI problems. With this in mind, one should lay out the PCB using wide, short traces for the main current paths. The input capacitor, as well as the inductor and output capacitors, should be placed as close as possible to the IC pins.

The feedback resistor network (bq25010) must be routed away from the inductor and switch node to minimize noise and magnetic interference. To further minimize noise from coupling into the feedback network and feedback pin, the ground plane or ground traces must be used for shielding. This becomes important especially at high switching frequencies.

The following are some additional guidelines that should be observed:

- To obtain optimal performance, the decoupling capacitor from AC to VSS (and from USB to VSS) and the output filter capacitors from BAT/OUT to VSS should be placed as close as possible to the bq2501x, with short trace runs to both signal and VSS pins.
- All low-current VSS connections should be kept separate from the high-current charge or discharge paths from the battery. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.
- The BAT/OUT pin provides voltage feedback to the IC for the charging function and should be connected with its trace as close to the battery pack as possible.
- The high current charge paths into AC and USB and from the BAT/OUT and SW pins must be sized appropriately for the maximum charge or output current in order to avoid voltage drops in these traces.
- The bq2501x is packaged in a thermally enhanced MLP package. The package includes a thermal pad to provide an effective thermal contact between the IC and the printed circuit board (PCB). Full PCB design guidelines for this package are provided in the application note *QFN/SON PCB Attachment* (SLUA271).

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
BQ25010RHLLR	ACTIVE	VQFN	RHL	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	ANC	<a href="#">Samples</a>
BQ25010RHLLRG4	ACTIVE	VQFN	RHL	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	ANC	<a href="#">Samples</a>
BQ25012RHLLR	ACTIVE	VQFN	RHL	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	ANF	<a href="#">Samples</a>
BQ25012RHLLRG4	ACTIVE	VQFN	RHL	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	ANF	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25010RHLR	VQFN	RHL	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1
BQ25012RHLR	VQFN	RHL	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1

## TAPE AND REEL BOX DIMENSIONS

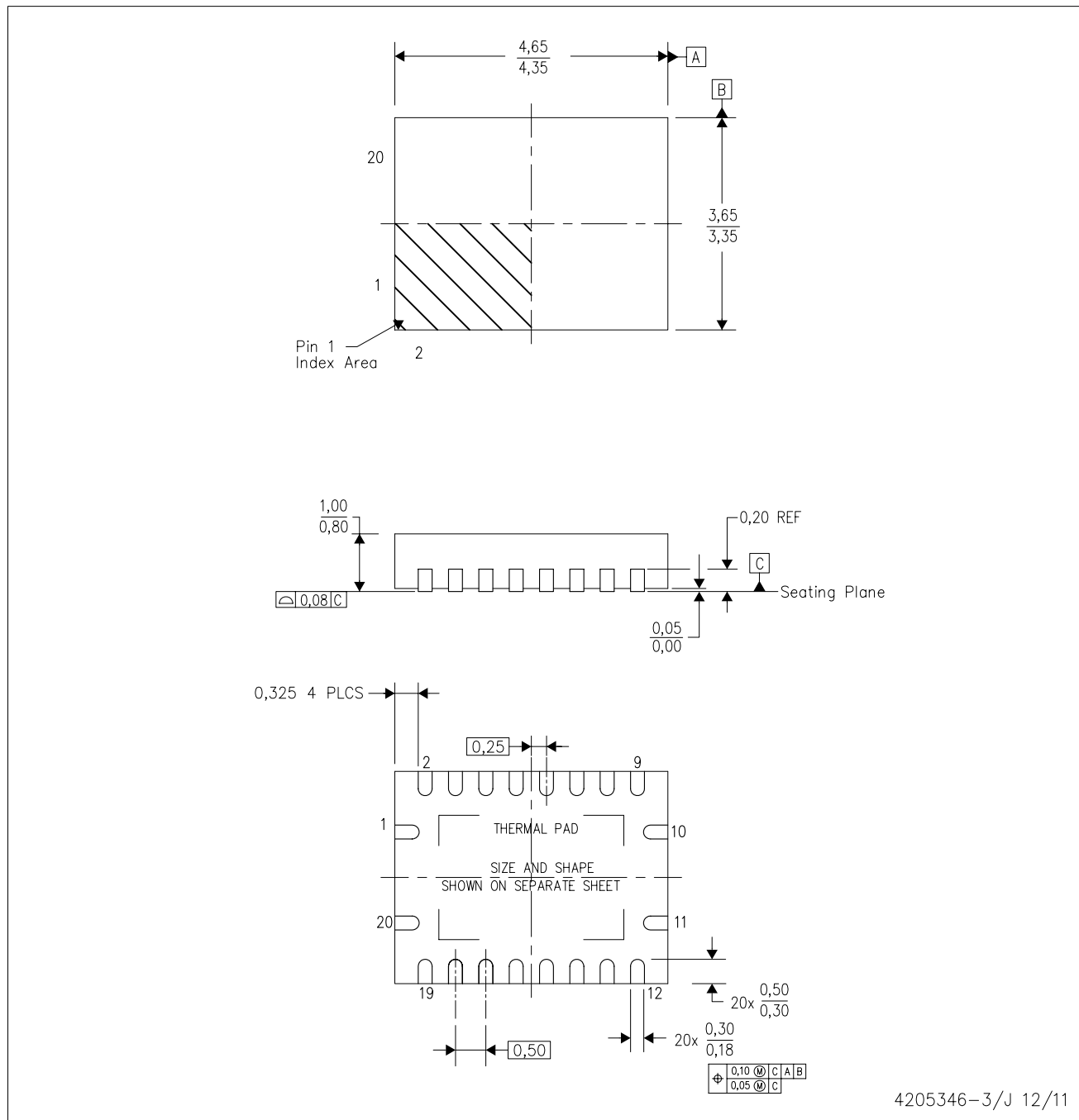


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ25010RHLR	VQFN	RHL	20	3000	367.0	367.0	35.0
BQ25012RHLR	VQFN	RHL	20	3000	367.0	367.0	35.0

RHL (R-PVQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



4205346-3/J 12/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. QFN (Quad Flatpack No-Lead) Package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.



RHL (S-PVQFN-N20)

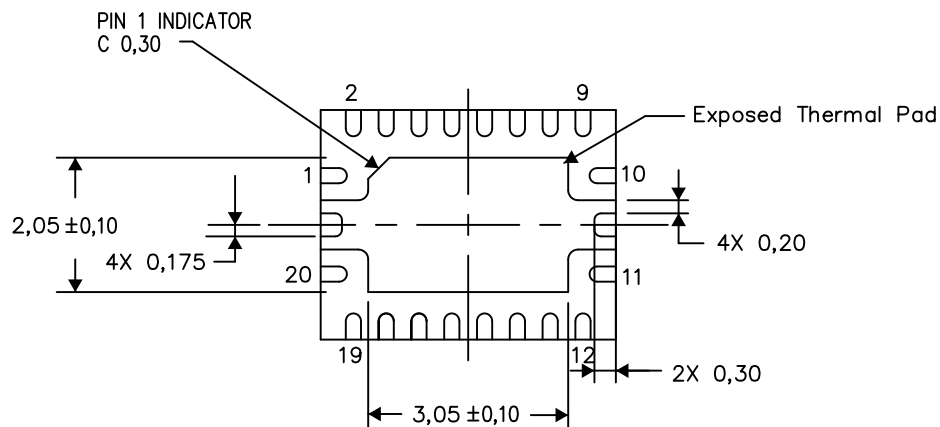
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

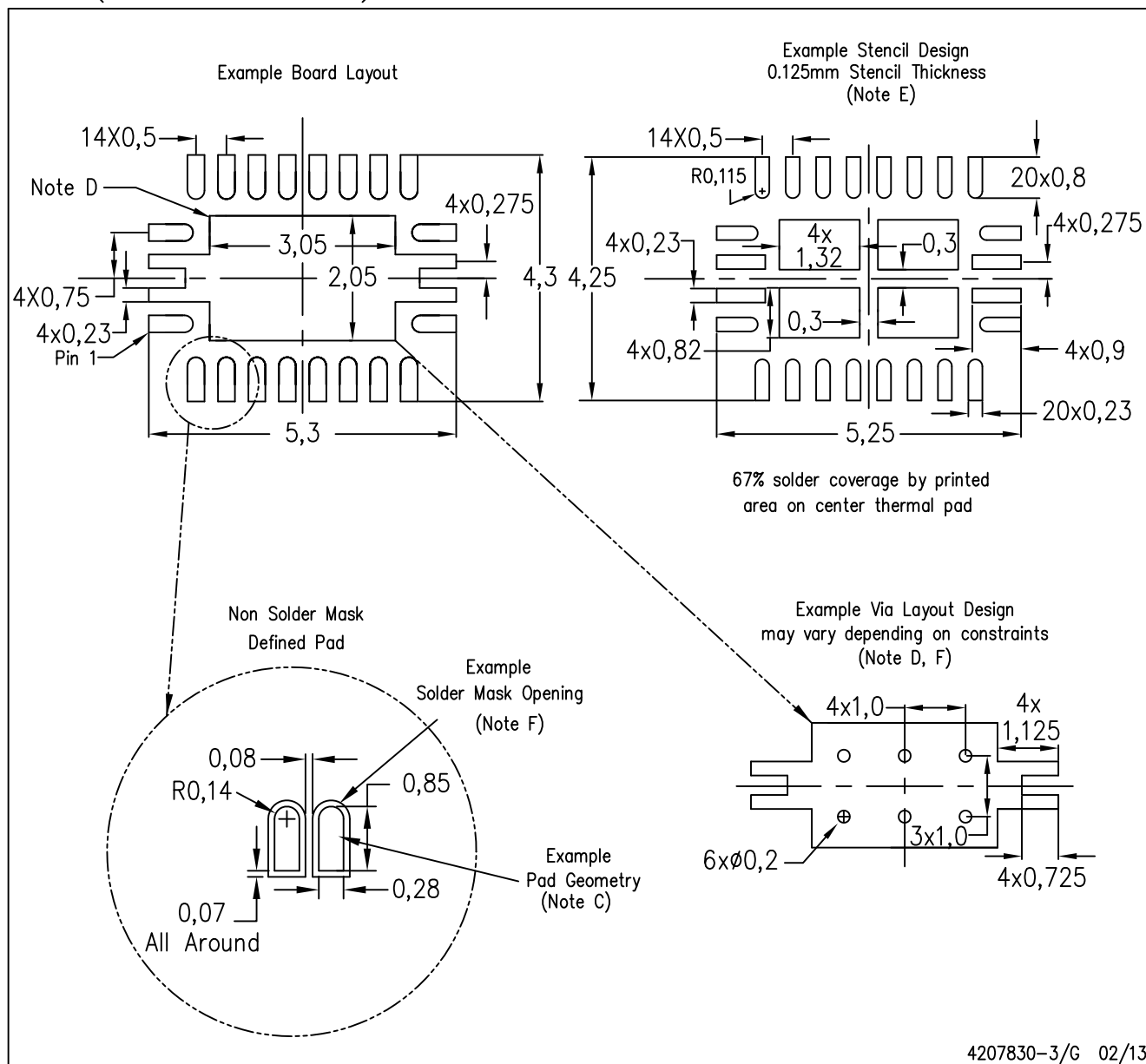
Exposed Thermal Pad Dimensions

4206363-3/M 08/12

NOTE: All linear dimensions are in millimeters

RHL (R-PVQFN-N20)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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